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IEEE RAMS 2024 Table of Contents

1C Life Data Analysis

Do Bayesian Neural Networks Weapon System Improve Predictive Maintenance (170)...1
***Michael Potter**, Naval Surface Warfare Center - Corona (United States); Miru Jun, (United States); Edward Schuberg, (United States)*

A Simple Statistical Approach to Fix Effectiveness Demonstration for Eliminated Mechanisms (36)...8
***Todd Marquart**, Micron Technology (United States)*

Statistical Estimation of the Minimal Resistance Threshold. Case study of Automotive Heat Exchangers (46)...13
***Marco Bonato**, VALEO Thermal Systems FRANCE (France); Lambert Pierrat, LJ-Consulting (France)*

1E Design Optimization Using R&M Techniques - 1

Lessons Learned from HALT, HASS, and Accelerated Aging Testing (134)...19
***Allan Hill**, Lockheed Martin Missiles and Fire Control (United States)*

Multitask Modeling for Reliability Analysis and Design with Partial Information (194)...23
*Yanwen Xu, University of Texas at Dallas (United States); Yulun Wu, University of Illinois at Urbana Champaign (United States); Yumeng Li, (United States); **Pingfeng Wang**, University of Illinois at Urbana-Champaign (United States)*

Captive Fleet Size and Usage Accumulation Determination and Optimization (48)...29
***Feng-Bin Sun**, Tesla Inc. (United States); Richard Baker, Tesla Inc. (United States)*

Automated Addressing Failure Detection for Multiplexer Systems (7)...35
***Gwyer Sinclair**, NASA (United States)*

2C Reliability Modeling - 1

Validation and Adjustment of Prior Distributions to Improve Bayesian Reliability Analysis for Beta-Binomial Data (56)...41
***Zhaofeng Carl Huang**, Aerospace Corporation (United States)*

Planning Inspection Intervals for Degradation Tests (71)...48
***Rong Pan**, Arizona State University (United States); Guanqi Fang, Arizona State University (United States)*

Estimating the duration of failure-based reliability demonstration tests (172)...54
***Philipp Mell**, Institute of Machine Components, University of Stuttgart (Germany); Martin Dazer, University of Stuttgart (Germany)*

Introduction to a Binomial Approach to Accelerated Life Testing (2)...61
***Reuel Smith**, University of Maryland (United States); Sherief Elsibaie, (United States); Mohammad Modarres, University of Maryland (United States)*

2D Availability

Leveraging MBSE to Analyze Reliability, Maintainability and Availability for System-of-Systems (120)...67
***Jordan Suls**, G2 Ops (United States)*

A Preliminary Availability Assessment of A LEO Satellite Constellation (158)...73
***Wei Huang**, Maxar Space Systems (United States)*

Defining the Aspects of Mean Logistics Down Time (MLDT) (84)...79
***Chris Fasula**, Raytheon (United States); Gary Pedro, Raytheon (United States); Jaime Franqui, Raytheon Technologies (United States)*

Maximum Likelihood with the Two-Parameter Exponential Model and Interval-Censored Data (53)...85
***Michael Spivey**, (United States)*

2E R&M Applications in Aerospace - 1

Reliability - an Emergent System Property,737 MAX and Societal System Examples (190)...92
***Jan Smith**, PMF Series (United States)*

Risk Assessment in Concurrent Engineering of Space Missions (3)...100
***Antonio Harrison Sanchez**, European Space Agency (Netherlands)*

A Case Study Using Failure Mode Effect Testing to Support the MIL-HDBK-516C Airworthiness Certification (88)...105
***Yangyang Yu**, General Atomics Aeronautical Systems, Inc. (GA-ASI) (United States); Blair Schemidt, GA-ASI (United States); Vanessa Swope, General Atomics Aeronautical Systems, Inc. (United States)*

3C Reliability Growth Analysis and Digital Twin

High Reliability at Minimum Cost (79)...111
***Harry Jones**, NASA (United States)*

The abcd Reliability Growth Model (81)...116
***Harry Jones**, NASA (United States)*

3D Autonomous Systems and AI - 1

MLOps FMEA: A Proactive & Structured Approach to Mitigate Failures for Machine Learning Operations (139)...121
***Abhishek Paul**, Northrop Grumman (United States); Roderick Son, Northrop Grumman (United States); Kenney Crooks, Northrop Grumman Systems (United States)*

The use and misuse of Pre-Trained Generative Large Language Models in Reliability Engineering (72)...128
***Yunwei Hu**, Schneider Electric (United States); Yavuz Goktas, Schneider Electric (United States); DAVID YELLAMATI, Schneider Electric (United States); Catherine DE TASSIGNY, Schneider Electric (France)*

Measures and Metrics of ML Data and Models to Assure Reliable and Safe Systems (51)...135
*Benjamin Werner, US Army DEVCOM AC (United States); **Benjamin Schumeg**, US Army DEVCOM AC (United States); Shane Hall, (United States); Jon Vigil, (United States); Mikel Petty, University of Alabama in Huntsville (United States); Ben Thengvall, (United States)*

3E R&M Management

Oh, the Places They Will GoTo Safely Save Lives: Case Study of a HRO Medical Aviation Program (159)...141
***Catherine Fernald**, ChristianaCare (United States); John Roussis, (United States)*

Human Reliability under Physical Security Threats: Modeling and Experiment Design (185)...147
***Md Ragib Rownak**, The Ohio State University (United States); Xiaoxu Diao, The Ohio State University (United States); Carol Smidts, The Ohio State University (United States)*

Reliability Culture –The Key to a Reliable and Sustainable Asset Uptime (29)...153
***Adeolu Adegboye**, Solūtiōnem Coy Ltd (Nigeria)*

5C Maintenance Models and Methodologies - 1

A new maintenance plan for wind turbine farms using reinforcement learning (154)...158
*hasan rasay, (); Fatemeh Safaei, Ryerson university (Canada); **Sharareh Taghipour**, Toronto Metropolitan University (Canada)*

Sensor and Maintenance Strategy Evaluation for Boeing 767 Commercial Fleets (113)...165
***Lukmon Rasaq**, (United States); Korbin Ferguson, North Carolina A&T State University (United States); William Teasley, North Carolina A&T State University (United States); Max Xu, Georgia Tech Research Institute (United States); Kyle Blond, Georgia Tech Research Institute (United States); Om Prakash Yadav, North Carolina A&T State University (United States)*

Spare Policy Identification for Enhancing Material Management through Stock Holding Policy Program (98)...171

***Agustinus Priyantomo**, Pupuk Indonesia (Indonesia); Nanda Arief Wirawan, Pupuk Indonesia Holding Company (Indonesia); Ericcson Ramadhan, Pupuk Indonesia (Indonesia)*

System Performance Metrics of Complex Networks: Resilience vs. Availability (31)...177
***Donald Dzedzy**, (United States); Bilal Ayyub, (United States)*

5E Accelerated Life Testing - 1

Degradation Testing of Thermoelectrics for HVAC Applications (131)...183
***Julio Pulido**, Phononic (United States)*

Investigating Practical Orthogonality Deviations in RSM for Optimized Predictive Reliability Modeling (105)...189
***Marco Arndt**, Institute of Machine Components - University of Stuttgart (Germany); Martin Dazer, University of Stuttgart (Germany)*

Early detection of Failure in Solid State Devices using 4 Corner Targeted Testing (4)...195
***Ayswarya Rajagopalan**, Western Digital Corporation (United States); Bradley Guerke, Western Digital Corporation (United States); Jimmy Yang, Western Digital Corporation (United States)*

Quantum Computing Optimization: Application and Benchmark in Critical Infrastructure Assessment (148)...200
***Gabriel San Martin**, University of California Los Angeles (United States); Enrique Lopez Droguett, UCLA (United States)*

6C R&M Applications - 1

Assessing Robustness and Vulnerability in Interdependent Network Infrastructure: A Multilayer Network Approach (149)...207
***Phat Huynh**, University of South Florida (United States); M Mishkatur Rahman, North Dakota State University (United States); Om Prakash Yadav, North Carolina A&T State University (United States); Trung Le, University of South Florida/North Dakota State University (United States); Chau Le, (United States)*

Effective Supplier Reliability Introduction to Supply Chain & Supplier Quality Programs (20)...214
***Sarath Jayatilleka**, nVent (United States)*

Integrated Obsolescence Impact Assessments using a Readiness Based Spares Modeling Tool (60)...220
***Randall Lindsay**, RTX (United States); Joshua Danker, Raytheon Technologies (United States); Erik Schmidtberg, Raytheon (United States); Nobel Mathew, Raytheon (United States)*

A UAV Case Study on an MBSE workflow with Integrated Modular Safety and Reliability Analysis (95)...225
*Bernhard Kaiser, Ansys (Germany); **Michael Soden**, Ansys (Germany); Nils Heuermann, ANSYS Germany GmbH (Germany)*

6E Reliability Modeling - 2

A cumulative shock model with random failure threshold and a change point (201)...232
Yousof Shamstabar, (Iran); Fatemeh Safaei, Ryerson university (Canada); ***Sharareh Taghipour****, Toronto Metropolitan University (Canada)*

Reliability and Availability Analysis of Photovoltaic Systems (106)...238
Kim Dominik Hintz*, University of Stuttgart (Germany); Martin Dazer, University of Stuttgart (Germany)*

Reliability Goalsetting (13)...245
Vinayak Hegde*, Procept Biorobotics (United States)*

7C Risk Analysis and Management - 1

A Case Study on an End-to-End Safety Risk Management Process (93)...249
DAVID YELLAMATI*, Schneider Electric (United States); Yavuz Goktas, Schneider Electric (United States); Yunwei Hu, Schneider Electric (United States)*

Early Risk Assessment Based on Partial Information (111)...256
Paul Franklin*, McKissack and McKissack (United States)*

AOQL Metric's Robustness to Manufacturing Process Instability (17)...259
Kristen Gore*, Willamette University (United States); Daniel Smith, Willamette University (United States)*

7D FMEA

Implementing an Effective FRACAS Program as a Key DFR Solution (145)...265
Sarath Jayatilleka*, nVent (United States)*

Design Failure Mode Effects and Criticality Analysis, Industry Best Practices (41)...270
Vinayak Hegde*, Procept Biorobotics (United States)*

Failure Report And Corrective Action System a Closed Loop System (14)...275
Vinayak Hegde*, Procept Biorobotics (United States)*

P-Diagram Driven Robust PFMEA Development (136)...280
Yavuz Goktas*, Schneider Electric (United States); Yunwei Hu, Schneider Electric (United States); DAVID YELLAMATI, Schneider Electric (United States)*

7E Reliability Modeling - 3

ARCS-R: Mission Critical Combined Reliability and Cybersecurity Systems Engineering Analysis (176)...287
Douglas Van Bossuyt*, Naval Postgraduate School (United States); Nikolaos*

Papakonstantinou, VTT Technical Research Centre of Finland (Finland); Britta Hale, Naval Postgraduate School (United States); Ryan Arlitt, Technical University of Denmark (Denmark)

Estimating Multi-Phase Life Cycle Reliability by Combining Failure Rate Adjustments into Duty Cycle (44)...295
***Miklós Szidarovszky**, Raytheon (United States)*

Reliability Analysis of Interdependent Stochastic-Flow Networks (140)...300
***Risat Rimi Chowdhury**, North Carolina A&T State University (United States); Om Prakash Yadav, North Carolina A&T State University (United States); Shah M Limon, Slippery Rock University of Pennsylvania (United States)*

A Reliability and Availability Model of a Kubernetes Cluster using SysML (160)...306
***Myron Hecht**, Aerospace Corporation (United States); Scott Agena, Aerospace Corp (United States)*

8C Diagnostics and Prognostics

Sensor Placement and Fault Detection in Electric Motor using Stacked Classifier and Search Algorithm (195)...313
***Sara Kohtz**, University of Illinois at Urbana-Champaign (United States); Pingfeng Wang, University of Illinois at Urbana-Champaign (United States)*

Anomaly Detection in Graph-Based Data utilizing Graph Topology (165)...318
***Ibrahim Ahmed**, University of Miami (United States); Ramin Moghaddass, University of Miami (United States)*

Sensor implementation for saltwater ingress detection in deep-sea actuators (67)...324
***Markus Hiller**, Aalen University (Germany); Sebastian Imle, Advanced Mechatronics GmbH (Germany); Markus Glaser, Aalen University, Institute for High Integrity Mechatronic Systems (Germany)*

Assuring Reliability of Autonomous Commercial Drones in the National Airspace (54)...330
***Matthew Litton**, Naval Postgraduate School (United States); Doron Drusinsky, Naval Postgraduate School (United States); James Michael, Naval Postgraduate School (United States)*

8D Warranty Data Analysis and Management

Root Cause analysis of Intermittent digital system Reset and its reliability evaluation (42)...336
*Cher Ming Tan, Moxa Inc. (Taiwan); **Chiarenn Wang**, Moxa Inc. (Taiwan)*

Pre-mature reliability degradation of 5G Network Electronics in unknown hostile environment (73)...342
Cher Ming Tan, Moxa Inc. (Taiwan); ***Chiarenn Wang****, Moxa Inc. (Taiwan)*

Investigating the Impact of Covid Pandemic on 12V Battery Failures Through Reliability Modeling (96)...348
Pietro Fanelli*, CNH Industrial (Belgium); Dharmjeet Verma, CNH Industrial (India); Mathew Thomas, CNH Industrial (United States)*

Boosting Warranty Data Analysis with Natural Language AI Algorithms (39)...354
Fabio Verdinelli*, CNH INDUSTRIAL (Italy); Mathew Thomas, CNH Industrial (United States)*

8E Design Optimization Using R&M Techniques - 2

Reliability Focused Six Sigma Approach (104)...360
Hemant Urdhwareshe*, Institute of Quality and Reliability (India); Chetan Prabhu, Symbiosis Institute of International Business (India)*

An integrated approach to Level of Repair optimization (119)...364
Gustaf Solveling*, Systecon North America (United States); Steve Keeling, Systecon North America (United States)*

Machine Learning Qualification Process and Impact to System Assurance (52)...370
Benjamin Werner*, US Army DEVCOM AC (United States); Benjamin Schumeg, US Army DEVCOM AC (United States); Jason Summers, (United States); Visar Berisha, (United States)*

A Probabilistic Model for Estimating Defect-limited Yield of ASICs (82)...376
Lixian Huang*, Teradyne, inc. (United States); Karthik Sankaran, (United States); Kamran Hakim, (United States); Ali Mosleh, UCLA (United States)*

9C R&M Applications - 2

FMEA & FTA integration in MBSE approach for Healthcare Systems & Solutions (65)...382
Olaf van der Burgt*, Philips (Netherlands); Mehmet Firat Parlatan, Philips (Netherlands)*

Integrating R&M throughout UAF, Case Study: NASA Infrastructures (174)...388
Roohollah Heidary*, Global Technology Connection Inc (United States); Jesse Williams, Global Technology Connection Inc (United States); Olivia J Fischer, Georgia Institute of Technology, Aerospace Systems Design Laboratory (ASDL) (United States); Scott J Duncan, Georgia Institute of Technology, Aerospace Systems Design Laboratory (ASDL) (United States); Matthew W. Dosberg, NASA Goddard Space Flight Center (United States); Jubilee Prasad Rao, Global Technology Connection Inc (United States)*

Challenges Faced in Electric Vehicle Adoption (22)...395
Keith Janasak*, Raytheon Technologies, Retired (United States)*

Common Maintenance Task Analysis for Maintainability & Tech Manual Development (58)...401
***Joshua Danker**, Raytheon Technologies (United States); Michael Flanagan, Raytheon (United States); Erik Schmidtberg, Raytheon (United States); Nobel Mathew, Raytheon (United States)*

9D Accelerated Life Testing - 2

Reliability Prediction via Accelerated Testing with Imperfectly Controlled Conditions (109)...407
***Cesar Ruiz**, University of Oklahoma (United States); Farid Hashemian, University of Arkansas (United States); Haitao Liao, University of Arkansas (United States)*

A Comparison of Pearl String and Horizon Method in Terms of Reliability Demonstration Testing (100)...413
***Achim Benz**, Institute of Machine Components, University of Stuttgart (Germany); Martin Dazer, University of Stuttgart (Germany)*

Timely Risk Analysis Using Comparative Accelerated Life Testing (162)...419
***Greg Cennamo**, Lincoln Electric (United States)*

End-of-Life Reliability Predictions for Compressors along the Service Life (191)...425
***Sarath Jayatilleka**, nVent (United States)*

9E Prognostics and Health Management

A Deep Learning Approach for Discovering the Underlying Physics of Degradation for Data-Driven Prognostics (132)...431
***Hamidreza Habibollahi Najaf Abadi**, Center for Risk and Reliability, University of Maryland (United States); Mohammad Modarres, University of Maryland (United States)*

Impact of AI-assisted System on Vehicle Maintenance: A System Dynamics Approach (156)...437
***Wei Li**, Northeastern University (United States); Guoyan Li, Northeastern Univeristy (United States); Sagar Kamarthi, Northeastern University (United States)*

High-voltage circuit breaker condition-dependent failure rate with covariates (11)...443
***Jordon Grant**, NTNU (Norway); Håkon Toftaker, SINTEF (Norway); Samuel Perkin, Landsnet (Iceland); Iver Bakken Sperstad, SINTEF Energy Research (Norway); Vijay Venu Vadlamudi, Norwegian University of Science and Technology (Norway)*

11C Fault Tree Analysis

Querying Fault and Attack Trees: Property Specification on a Water Network (125)...449
***Stefano M. Nicoletti**, University of Twente (Netherlands); Milan Lopuhaä-Zwakenberg, (Netherlands); E. Moritz Hahn, (Netherlands); Mariëlle Stoelinga, University of Twente (Netherlands)*

SAFEST: Fault Tree Analysis via Probabilistic Model Checking (150)...455
***Mariëlle Stoelinga**, University of Twente (Netherlands); Matthias Volk, Eindhoven University of Technology (Netherlands); Joost-Pieter Katoen, (Germany); Falak Sher, (United States)*

Fault Management Algorithm Risk Assessment for the NASA Space Launch System (175)...462
***William Maul**, HX5 LLC (United States); Yunnhon Lo, ERC, LLC. (United States); Edmond Wong, NASA Glenn Research Center (United States)*

Solving large fault trees with importance sampling and tree search (87)...468
***Yunfei Zhao**, University of Maryland, College Park (United States); Joseph O'Leary, University of Maryland, College Park (United States)*

11E Maintenance Models and Methodologies - 2

Digital Engineering Transformation for Reliability/Maintainability (117)...474
***Raymond Beshears**, Raytheon Technologies (United States); Jordan Long, Raytheon (United States)*

An Automated Performance Evaluation of the Newborn Life Support Procedure (124)...479
*Alfian Tan, University of Nottingham (United Kingdom); Joy Egede, University of Nottingham (United Kingdom); **Rasa Remenyte-Prescott**, University of Nottingham (United Kingdom); Michel Valstar, BlueSkeye AI (United Kingdom); Don Sharkey, University of Nottingham (United Kingdom)*

12C Physical Reliability Models

Scaled Reliability Prediction Model for Gallium Nitride (GaN) Monolithic Microwave Integrated Circuit (1)...485
***Onovughakpor (Ono) Kedienhon**, Northrop Grumman (United States)*

Assessing sustainment and mission impacts associated with Next Generation Aviation Systems (102)...489
***Geetha Chary**, DEVCOM Analysis Center (DAC) (United States); Shawn Brady, (United States); Martin Wayne, US Army DEVCOM Analysis Center (United States); David Mortin, ()*

New Trends in Testing Electronic Products by Simulation During Design Using Programmable Rules, Circuit Analysis and AI (142)...495
***Yizhak Bot**, BQR (Israel); Amir Segal, BQR (Israel)*

Exploratory Data Analysis for Failure Detection and Isolation in Complex Systems (94)...502
***Navid Zaman**, PHM Technology (Australia); Daniel Chan, PHM Technology (Australia); You Jung Jun, PHMT (Australia)*

12E Autonomous Systems and AI - 2

Hybrid-AI Approach to Health Monitoring of Vehicle Control System (144)...507
***Kenneth Lu**, Charles River Analytics (United States)*

Unsupervised Anomaly Detection in Electric Power Networks Using Multi-layer Auto-encoders (152)...512
***Phat Huynh**, University of South Florida (United States); Gurmeet Singh, North Dakota State University (United States); Trung Le, University of South Florida/North Dakota State University (United States); Om Prakash Yadav, North Carolina A&T State University (United States); Chau Le, (United States)*

Efficient Real-Time Continuous Classification Learning and Fault-Tolerant Computing (153)...518
***Meng-Lai Yin**, Cal Poly Pomona (United States)*

Redundancy: How Many Unreliable Spares are Needed for High Reliability and Confidence? (80)...524
***Harry Jones**, NASA (United States)*

13C Software Reliability and Testing

Three-Stage Adjusted Regression Forecasting for Software Defect Prediction (135)...530
***Vidhyashree Nagaraju**, (United States); Bhaskar Mitra, Pacific Northwest National Laboratory (United States); Shadow Pritchard, The Boeing Company (United States)*

DevSecOps Process Assessment Collaboration Tool: A Novel Method to Inject R&M Into Agile Development (89)...536
***Joseph Lazarus**, STAT COE (United States); Lenny Truett, STAT COE (United States); Brittany Fischer, (United States); **Christopher Kershner**, STAT COE (United States)*

Machine learning methods for predicting software failures (37)...541
***Ann Neufelder**, Mission Ready Software (United States)*

Software Error Classification and Dependency Assessment for NASA Missions (179)...547
***Leila Meshkat**, Jet Propulsion Laboratory, California Institute of Technology (United States); Ying Shi, ()*

13E Risk Analysis and Management - 2

An STPA-based analysis of Automated Driving Systems fleet maintenance activities (129)...553
***Camila Correa-Jullian**, The B. John Garrick Institute for the Risk Sciences - UCLA (United States); Marilia Ramos, The B. John Garrick Institute for the Risk Sciences - UCLA (United States); Ali Mosleh, UCLA (United States); Jiaqi Ma, ()*

Game-theoretic and probabilistic cyber risk assessment (92)...559
***Yunfei Zhao**, University of Maryland, College Park (United States)*

Integrated Systems Engineering, Safety, Reliability and Risk Management - Minimizing Black Swan Events (68)...565
***Prince Kalia**, NASA - Goddard Space Flight Center (United States); Michael Menzel, NASA - Goddard Space Flight Center (); Angelia Walker, NASA Marshall Space Flight Center (United States); Kyle Grello, NASA - GSFC (United States)*

14C Reliability Modeling - 4

Identifying and Rectifying the Potential Faults in the Probabilistic Metric Formula in ISO 26262 (19)...571
***Atsushi SAKURAI**, FS Micro Corporation (Japan)*

A Meta-analysis of Miner's Rule (115)...577
***Lance Curtis**, University of Maryland (United States); Bilal Ayyub, (United States)*

Use of Reliability Assessment Techniques to Verify Product Field Performance (77)...583
***Pankaj Shrivastava**, Halliburton (United States); Bob Gissler, Halliburton (United States)*

An Exact Formula for the Hazardous Event Frequency (138)...589
***Armin Zimmermann**, Technische Universität Ilmenau (Germany); Andreas Hildebrandt, Pepperl+Fuchs SE (Germany)*

14D R&M Applications in Aerospace - 2

Use and Misuse of Reliability Analysis for Unmanned Spacecraft Missions (169)...595
***Jeffrey Dawson**, NASA (United States)*

Reliability Stress-Strength Modeling Demystified (27)...601
***Kenneth Murphy**, Lockheed Martin Space Systems Company (United States)*

Probability of Disposal Demystified (26)...607
***Kenneth Murphy**, Lockheed Martin Space Systems Company (United States)*

14E Big Data and IoT Applications in R&M

Reliability Improvement of Rainwater Drainage System Using IoT and AI (5)...613
***Ryuichi Sekita**, Fukuyama University (Japan); Teppei Watanabe, NICHIATSUKIHAN Co.Ltd (Japan); Tadashi Yoshizawa, SERIALGAMES Inc., (Japan); Kenta Nakanishi, Nita Consultant Co., Ltd (Japan)*

Applying Design of Experiments in Testing and Validation of Statistical Software (171)...619
***Caleb King**, JMP Statistical Discovery, LLC (United States); Ryan Lekivetz, JMP Statistical Discovery LLC (United States); Joseph Morgan, SAS Institute (United States)*

The Liability of Reliability (23)...625
Rick Jones, Hartford Steam Boiler Inspection & Insurance Company (United States); ***Dwayne Mason****, Greenberg Traurig LLP (United States)*